

STB9NK60ZD

Datasheet - production data

N-channel 600 V, 0.85 Ω typ., 7 A Zener-protected SuperFREDMESH[™] Power MOSFET (with fast diode) in D²PAK

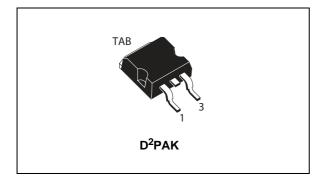
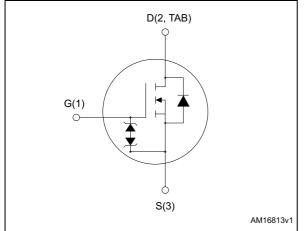


Figure 1. Internal schematic diagram



Features

| Order code | V_{DS} | R _{DS(on) max} . | I _D | P _{TOT} |
|--------------|----------|---------------------------|----------------|------------------|
| STB9NK60ZDT4 | 600 V | 0.95 Ω | 7 A | 125 W |

- Extremely high dv/dt capability
- Zener-protected
- 100% avalanche tested
- Gate charge minimized
- Low intrinsic capacitances
- Fast internal recovery diode

Applications

- Switching applications
- Fast internal recovery diode

Description

The device is developed using the revolutionary SuperFREDMesh[™] technology. It associates all advantages of reduced on-resistance, Zener gate protection and very high dv/dt capability with a fast body-drain recovery diode. Such series complements the "FDmesh[™]" advanced technology.

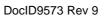
Table 1. Device summary

| Order code | Order code Marking | | Packaging | |
|--------------|--------------------|--------------------|---------------|--|
| STB9NK60ZDT4 | B9NK60ZD | D ² PAK | Tape and reel | |

This is information on a product in full production.

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Electrical ratings

| Symbol | Parameter | Value | Unit |
|--------------------------------|---|-------------|------|
| V _{DS} | Drain-source voltage | 600 | V |
| V _{GS} | Gate-source voltage | ±30 | V |
| I _D | Drain current (continuous) at $T_C = 25 \text{ °C}$ | 7 | А |
| ۱ _D | Drain current (continuous) at $T_C = 100 \ ^{\circ}C$ | 4.3 | А |
| I _{DM} ⁽¹⁾ | Drain current (pulsed) | 28 | А |
| D | Total dissipation at $T_C = 25 \text{ °C}$ | 125 | W |
| P _{TOT} | Derating factor | 1 | W/°C |
| V _{ESD(G-S)} | Gate-source ESD (HBM-C=100 pF, R=1.5 kΩ) | 4000 | V |
| dv/dt ⁽²⁾ | Peak diode recovery voltage slope | 15 | V/ns |
| Тj | Max. operating junction temperature | - 55 to 150 | ℃ |
| T _{stg} | Storage temperature | - 55 10 150 | |

Table 2. Absolute maximum ratings

1. Pulse width limited by safe operating area.

2. $I_{SD} \leq$ 7 A, di/dt \leq 500 A/µs; V_{DD} = 80% $V_{(BR)DSS}$.

Table 3. Thermal data

| Symbol | ymbol Parameter Value | | Unit |
|-----------------------|---|----|------|
| R _{thj-case} | Thermal resistance junction-case max. | 1 | °C/W |
| R _{thj-pcb} | Thermal resistance junction-pcb max. ⁽¹⁾ | 30 | °C/W |

1. When mounted on 1 inch² FR-4, 2 Oz copper board.

Table 4. Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|-----------------|---|-------|------|
| I _{AR} | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax})$ | 7 | А |
| E _{AS} | Single pulse avalanche energy (starting T _j =25 °C, I _D = I _{AR} ; V _{DD} = 50) | 235 | mJ |



Electrical characteristics 2

(T_C = 25 °C unless otherwise specified)

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------|--|---|------|------|---------|----------|
| V _{(BR)DSS} | Drain-source breakdown voltage | I _D = 1 mA, V _{GS} = 0 | 600 | | | V |
| I _{DSS} | Zero gate voltage drain current (V _{GS} = 0) | V _{DS} = 600 V V _{DS} = 600 V, T _C = 125 °C | | | 1 50 | μA μA |
| I _{GSS} | Gate-body leakage current (V _{DS} = 0) | V _{GS} = ± 20 V | | | ±10 | μA |
| V _{GS(th)} | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 100 \ \mu A$ | 2.5 | 3.5 | 4.5 | V |
| R _{DS(on)} | Static drain-source on-resistance | V _{GS} = 10 V, I _D = 3.5 A | | 0.85 | 0.95 | Ω |

| Table | 5. | On | /off | states |
|-------|----|----|------|--------|
|-------|----|----|------|--------|

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|-------------------------------------|---------------------------------|---|------|------|------|------|
| g _{fs} ⁽¹⁾ | Forward transconductance | V _{DS} = 15 V, I _D = 3.5 A | - | 5.3 | | S |
| C _{iss} | Input capacitance | | - | 1110 | | pF |
| C _{oss} | Output capacitance | V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0 | - | 135 | | pF |
| C _{rss} | Reverse transfer capacitance | | - | 30 | | pF |
| C _{oss eq.} ⁽²⁾ | Equivalent output capacitance | $V_{DS} = 0$ to 480 V, $V_{GS} = 0$ | - | 72 | | pF |
| Qg | Total gate charge | | - | 41 | 53 | nC |
| Q _{gs} | Gate-source charge | V _{DD} = 480 V, I _D = 11 A, V _{GS} = 10 V (see <i>Figure 15</i>) | - | 8.7 | | nC |
| Q _{gd} | Gate-drain charge | | - | 21 | | nC |

1. Pulsed: pulse duration= $300 \ \mu$ s, duty cycle 1.5%.

2. $C_{oss \ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .



| Table 7. Switching times | | | | | | | | | |
|--------------------------|-----------------------|--|------|------|------|------|--|--|--|
| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit | | | |
| t _{d(on)} | Turn-on delay time | | - | 11.4 | - | ns | | | |
| t _r | Rise time | $V_{DD} = 300 \text{ V}, I_D = 3.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V} (see Figure 14 and Figure 19)$ | - | 13.6 | - | ns | | | |
| t _{d(off)} | Turn-off delay time | | - | 23.1 | - | ns | | | |
| t _f | Fall time | | - | 15 | - | ns | | | |
| t _{r(Voff)} | Off-voltage rise time | V _{DD} = 480 V, I _D = 7 A, | - | 11 | - | ns | | | |
| t _f | Fall time | $R_{G} = 4.7 \Omega$, $V_{GS} = 10 V$ (see | - | 8 | - | ns | | | |
| t _c | Cross-overtime | Figure 14 and Figure 19) | - | 20 | - | ns | | | |

Table 7. Switching times

| Table | 8. | Source - | drain | diode |
|-------|----|----------|-------|-------|
|-------|----|----------|-------|-------|

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|---------------------------------|-------------------------------|---|------|------|------|------|
| I _{SD} | Source-drain current | | - | | 7 | А |
| I _{SDM} ⁽¹⁾ | Source-drain current (pulsed) | | - | | 28 | А |
| V _{SD} ⁽²⁾ | Forward on voltage | $I_{SD} = 7 \text{ A}, V_{GS} = 0$ | - | | 1.6 | V |
| t _{rr} | Reverse recovery time | | - | 130 | | ns |
| Q _{rr} | Reverse recovery charge | I _{SD} = 7 A, di/dt = 100 A/μs V _{DD} = 30 V (see <i>Figure 16</i>) | - | 550 | | nC |
| I _{RRM} | Reverse recovery current | | - | 8.4 | | А |
| t _{rr} | Reverse recovery time | I _{SD} = 7 A, di/dt = 100 A/µs | - | 176 | | ns |
| Q _{rr} | Reverse recovery charge | $V_{DD} = 30 \text{ V}, \text{ T}_{j} = 150 \text{ °C}$ (see | - | 880 | | nC |
| I _{RRM} | Reverse recovery current | Figure 16) | - | 10 | | А |

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration= 300 μ s, duty cycle 1.5%.

Table 9. Gate - source Zener diode

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------------------|----------------------------------|-----------------------------|------|------|------|------|
| BV _{GSO} ⁽¹⁾ | Gate-source breakdown voltage | lgs= ± 1 mA (open drain) | 30 | | | V |

 The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.



Electrical characteristics (curves) 2.1

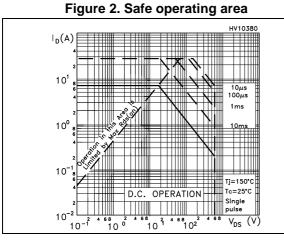


Figure 4. Output characteristics

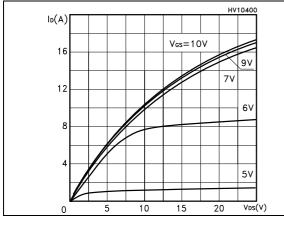
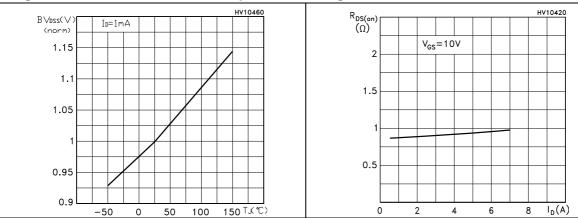


Figure 6. Normalized BVDSS vs temperature



 10^{-3} Figure 5. Transfer characteristics

0.01

SINGLE PULSE

10-4

 $Z_{th} = k R_{thJ-c}$

 10^{-1} $t_p(s)$

 $\delta = t_p / \tau$

 10^{-2}

Figure 3. Thermal impedance

к

 10^{-1}

10⁻²

10⁻⁵

 $\delta = 0.5$

0.2

0.

0.05

0.02

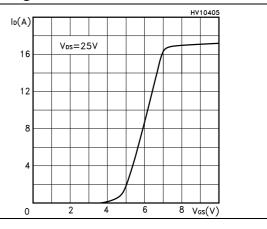


Figure 7. Static drain-source on-resistance





Figure 8. Gate charge vs gate-source voltage

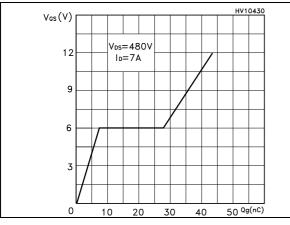


Figure 10. Normalized gate threshold voltage vs temperature

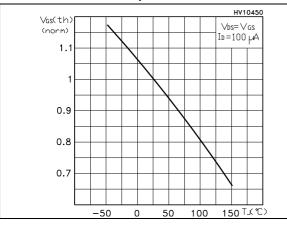


Figure 12. Source-drain diode forward characteristics

3

4

5

Isd(A)

2

HV10480

T_=-50 ℃

25°C

150 °C



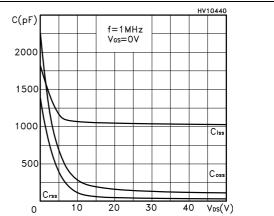


Figure 11. Normalized on-resistance vs temperature

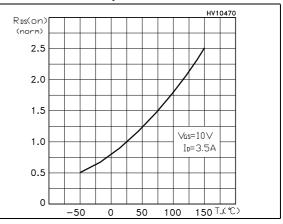
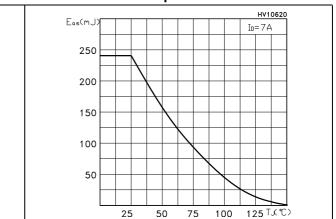


Figure 13. Maximum avalanche energy vs temperature





Vsd(V)

0.8

0.6

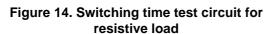
0.4

0.2

0

1

3 Test circuits



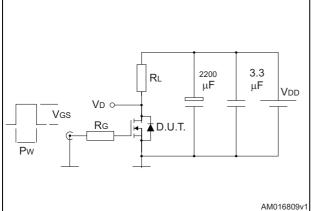


Figure 16. Test circuit for inductive load switching and diode recovery times

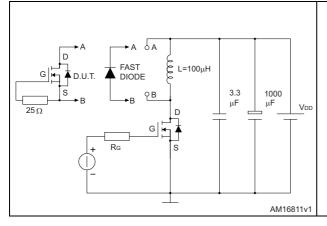


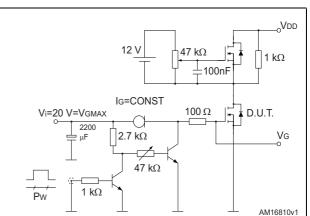
Figure 18. Unclamped inductive waveform

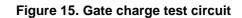
VD

IDM

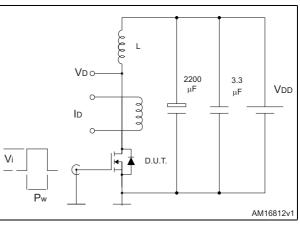
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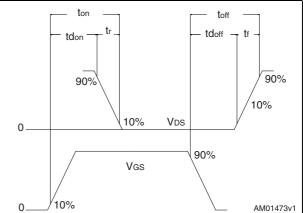
V(BR)DSS











47/

Figure 19. Switching time waveform



Vdd

AM01472v1



Vdd

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

| Dim | mm | | | | |
|--------|------|------|-------|--|--|
| Dim. — | Min. | Тур. | Max. | | |
| A | 4.40 | | 4.60 | | |
| A1 | 0.03 | | 0.23 | | |
| b | 0.70 | | 0.93 | | |
| b2 | 1.14 | | 1.70 | | |
| с | 0.45 | | 0.60 | | |
| c2 | 1.23 | | 1.36 | | |
| D | 8.95 | | 9.35 | | |
| D1 | 7.50 | | | | |
| E | 10 | | 10.40 | | |
| E1 | 8.50 | | | | |
| е | | 2.54 | | | |
| e1 | 4.88 | | 5.28 | | |
| н | 15 | | 15.85 | | |
| J1 | 2.49 | | 2.69 | | |
| L | 2.29 | | 2.79 | | |
| L1 | 1.27 | | 1.40 | | |
| L2 | 1.30 | | 1.75 | | |
| R | | 0.4 | | | |
| V2 | 0° | | 8° | | |

| Table 10. D ² PAK (TO-263) mechanical data |
|---|
|---|



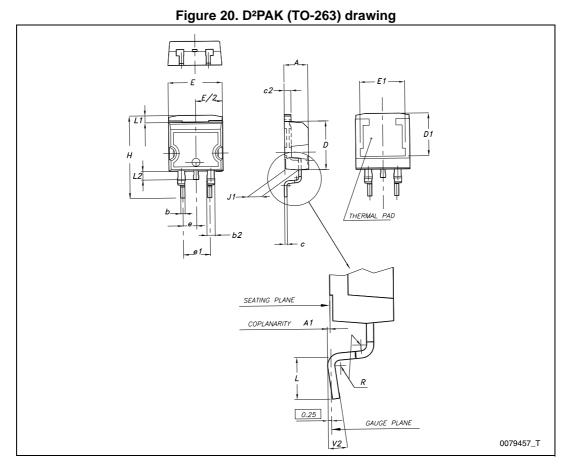
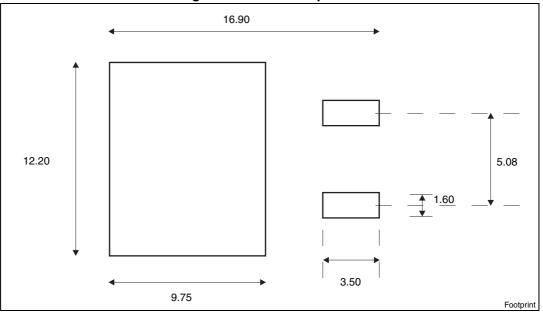


Figure 21. D²PAK footprint^(a)



a. All dimensions are in millimeters.

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5 Packaging mechanical data

| Table 11. D-PAR (10-203) tabe and feel mechanical data | | | | | | |
|--|------|------|------|----------|------|--|
| Таре | | | | Reel | | |
| Dim | mm | | Dim. | mm | | |
| | Min. | Max. | Dim. | Min. | Max. | |
| A0 | 10.5 | 10.7 | Α | | 330 | |
| B0 | 15.7 | 15.9 | В | 1.5 | | |
| D | 1.5 | 1.6 | С | 12.8 | 13.2 | |
| D1 | 1.59 | 1.61 | D | 20.2 | | |
| E | 1.65 | 1.85 | G | 24.4 | 26.4 | |
| F | 11.4 | 11.6 | N | 100 | | |
| K0 | 4.8 | 5.0 | Т | | 30.4 | |
| P0 | 3.9 | 4.1 | | | · | |
| P1 | 11.9 | 12.1 | | Base qty | 1000 | |
| P2 | 1.9 | 2.1 | | Bulk qty | 1000 | |
| R | 50 | | | | | |
| Т | 0.25 | 0.35 | | | | |
| W | 23.7 | 24.3 | | | | |

Table 11. D²PAK (TO-263) tape and reel mechanical data



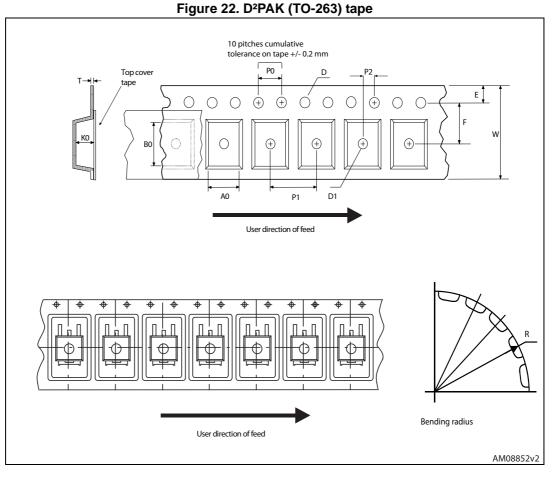
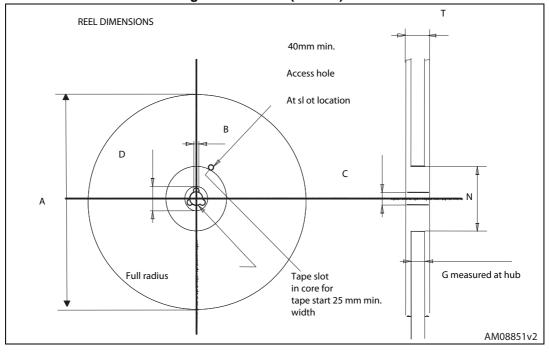


Figure 23. D²PAK (TO-263) reel



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A7

6 Revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 29-Sep-2003 | 6 | Data updated. |
| 13-Jun-2006 | 7 | The doc. has been reformatted. |
| 14-Apr-2008 | 8 | Table 8 has been corrected. Package mechanical data updated. |
| 11-Jul-2013 | 9 | The part numbers: STF9NK60ZD and STP9NK60ZD have been moved to a separate datasheet. Changed the title and <i>Figure 1</i>. Added Zener-protected to the features. Minor text changes. |

Table 12. Document revision history



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